FOR MATERIALS

TRENTO ETC* WORKSHOP / TRUSTWORTHY ML



Trustworthy machine learning for materials

Federico Grasselli – COSMO Lab EPFL

EPFL Uncertainty Quantification (UQ)

- Pillar of Scientific Method
- ML statistical nature
- Sources of uncertainty
- So far scarcely employed:
 - lack of standards
 - large cost (training and evaluation)
 - ad hoc training:
 - (MC dropout, deep and shallow ensembles, Gaussian mixture models, committees)



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EPFL Use of UQ in atomistic simulations

- Uncertainty aware simulations
- Reweight via committee of models



Imbalzano, Zhuang, Kapil, Rossi, Engel, Grasselli, and Ceriotti, J. Chem. Phys. 154, 074102 (2021)

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Loss:

$$\mathcal{L}(\mathbf{w}|D) = \sum_{i=1}^{N_{\text{train}}} \ell[\tilde{y}_i(\mathbf{x}_i, \mathbf{w}), y_i]$$

• How "rigid" is the prediction for a given input x_* ?

Loss:

$$\mathcal{L}(\mathbf{w}|D) = \sum_{i=1}^{N_{\text{train}}} \ell[\tilde{y}_i(\mathbf{x}_i, \mathbf{w}), y_i]$$

- How "rigid" is the prediction for a given input $x_\star ?$
- Constrained minimization of $\mathcal{L}_c = \mathcal{L} + \lambda (\epsilon_* \tilde{y}(\mathbf{x}_*, \mathbf{w}))$

Loss:

$$\mathcal{L}(\mathbf{w}|D) = \sum_{i=1}^{N_{\text{train}}} \ell[\tilde{y}_i(\mathbf{x}_i, \mathbf{w}), y_i]$$

- $\hfill \hfill \hfill$
- Constrained minimization of $\mathcal{L}_c = \mathcal{L} + \lambda (\epsilon_* \tilde{y}(\mathbf{x}_*, \mathbf{w}))$
- For $\epsilon_{\star} \approx \tilde{y}(\mathbf{x}_{\star}, \mathbf{w}_{o})$ we have $\mathcal{L}_{c}(\epsilon_{\star}|D) \approx \mathcal{L}(\mathbf{w}_{o}|D) + \frac{1}{2}R_{\star}(\epsilon_{\star} - \tilde{y}(\mathbf{x}_{\star}, \mathbf{w}_{o}))^{2}$

with

$$R_{\star} \equiv \frac{\partial^{2} \mathcal{L}}{\partial \epsilon_{\star}^{2}} \bigg|_{\epsilon_{\star} = \tilde{y}(\mathbf{x}_{\star}, \mathbf{w}_{o})} = \left[\frac{\partial \tilde{y}_{\star}}{\partial \mathbf{w}} \bigg|_{\mathbf{w}_{o}} \left[\frac{\partial^{2} \mathcal{L}}{\partial \mathbf{w}^{2}} \bigg|_{\mathbf{w}_{o}} \right]^{-1} \frac{\partial \tilde{y}_{\star}}{\partial \mathbf{w}} \bigg|_{\mathbf{w}_{o}} \right]^{-1}$$

Bigi, Chong, Ceriotti & Grasselli, arXiv:2403.02251 (2024)

- Fitted models: $P(\mathbf{w}) \propto \exp(-\mathcal{L}(\mathbf{w}))$
- Laplace approximation:
 - 2nd-order approximation of the loss
 - Gaussian approx. of the probability density



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• Linear regression:
$$\tilde{y} = \mathbf{w} \cdot \mathbf{x} \rightarrow \frac{\partial \tilde{y}}{\partial \mathbf{w}} \equiv \mathbf{x}$$

• PR is simple:

$$\boldsymbol{R}_{\star} = [\mathbf{X}_{\star} \cdot [\mathbf{X}^{\top} \mathbf{X}]^{-1} \mathbf{X}_{\star}]^{-1}$$

• $\frac{1}{R_{\star}}$ has got the same shape of variance in Gaussian process regression



EPFL What about Neural Networks?

- Statistical theory of NNs. Training and over-parametrization
- Central Limit Theorem \rightarrow infinitely wide NNs as Gaussian processes
- Last-layer features f



EPFL Last-Layer Prediction Rigidity

• Uncertainty simplifies to (the inverse of) Last-Layer PR:



EPFL Last-Layer Prediction Rigidity

• Uncertainty simplifies to (the inverse of) Last-Layer PR:



- Effectively the uncertainty of a linear model
- Very easy to calculate, two hyperparameters must be tuned
- Doesn't depend on target values of the training set

EPFL Last-Layer PR: results QM9 dataset



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EPFL Last-Layer PR results: California housing \$



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EPFL Last-Layer PR results

Very good uncertainty estimates across a wide variety of problems





EPFL **Last-Layer PR results**

Very good uncertainty estimates across a wide variety of problems

v=x

 6×10^{0}

Estimated variance

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	RMSE				NLL			
Dataset	PBP	MCD	DE	LLPR	PBP	MCD	DE	LLPR
Concrete	5.67:00	5.23 ±0.12	6.03:0.13	5.26	3.16+0.02	$3.04_{\pm 0.02}$	3.06:001	3.09
Energy	$1.80_{10.05}$	$1.66_{+0.04}$	2.09	$0.49_{\pm 0.03}$	2.04	$1.99_{\pm 0.02}$	$1.38_{10.05}$	0.69
Kin8nm	0.10	$0.10_{10.00}$	0.09	0.08	-0.90	-0.95	-1.20	-1.12
Naval	0.01	$0.01_{\pm 0.00}$	0.00	0.00	-3.73	$-3.80_{\pm 0.01}$	-5.63	$-7.07_{\pm 0.08}$
Power	4.12+0.03	$4.02_{\pm 0.01}$	4.11+0.01	3.94 +0.07	2.84	2.80	2.79±0.01	2.83+4.02
Protein	4.73	4.36	4.71	$4.18_{10.02}$	2.97:000	2.89	2.83	2.91
Wine	0.64	0.62	0.64	$0.63_{\pm 0.02}$	0.97	0.93±0.01	0.94	$1.02_{\pm 0.03}$
Yacht	1.02	1.11+0.08	1.58	1.19	1.63.0.02	1.55	1.18+0.05	1.58+4.20
Year	8.88.xxx	8.86 _{48/8}	8.89	8.91.ma	3.60.xxx	3.59 _{4N/A}	3.35 _{48/A}	3.61.ma





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EPFL Last-Layer PR: Summary

- Cheap, practical, scalable, a-posteriori
- Explains the success of last-layer approximations
- Pre-print on arxiv¹, code available @ https://github.com/frostedoyster/llpr



LLPR



PR for local predictions

- Atomistic models: local energies are **not** observables
- Yet used in
 - constructing ML models $E(A) = \sum_{i \in A} E_i$
 - heuristic analyses

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Adapted from Deringer, Pickard, Csányi. PRL 120 156001 (2018)



PR for local predictions

- Atomistic models: local energies are **not** observables
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 - constructing ML models $E(A) = \sum_{i \in A} E_i$
 - heuristic analyses





a defective icosahedron

vacant B13 site **B15**

B13

B15

fusec

 How robust are these? Use the same formulation of constrained loss, but now for *local predictions*

EPFL Local PR: amorphous silicon



EPFL Local PR: amorphous silicon



Chong, Grasselli, Ben Mahmoud, Morrow, Deringer and Ceriotti, JCTC 19, 8020 (2023)

EPFL Local PR: amorphous silicon

 Dramatic increase of local PR by adding structures containing under/over coordinated environments



EPFL Local PR: carbon films

Selective increase of local PR in low/high density carbon films





model trained on 1000 **amorphous** carbon structures replace 10 random structures with **crystalline diamond**

enhancement in LPR mostly for high density film

Chong, Grasselli, Ben Mahmoud, Morrow, Deringer and Ceriotti, JCTC 19, 8020 (2023)

EPFL Local PR: carbon films

Selective increase of local PR in low/high density carbon films





model trained on 1000 **amorphous** carbon structures

replace 10 random structures with crystalline graphite

enhancement in LPR mostly for low density film

Chong, Grasselli, Ben Mahmoud, Morrow, Deringer and Ceriotti, JCTC 19, 8020 (2023)

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EPFL Remarks, Conclusions and Outlook

- Low-cost uncertainty on new predictions for pretrained models
- Constrained loss minimization is just a theoretical tool:
 - no need to train a model with constrained loss to get PR and uncertainties
 - no need for target values
- Rigidity of local predictions is readily obtained with same formalism

EPFL Remarks, Conclusions and Outlook

- Sample last-layer weights according to Laplace approximation → ensemble
- Propagate uncertainty to derived quantities
- Use it on thermodynamic observables



Kellner & Ceriotti, https://arxiv.org/abs/2402.16621 (2024)

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Backup slides

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EPFL Use of UQ in atomistic simulations

Uncertainty aware simulations



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EXTENSION TO NEURAL NETWORKS

- Statistical theory of NNs. Training and over-parametrization
- Central Limit Theorem \rightarrow infinitely wide NNs as Gaussian processes
- Two deterministic kernels
 - Neural-Network Gaussian Process (NNGP)¹: initialization
 - Neural Tangent Kernel (NTK)²: training
- Distribution of predictions³ during training is Gaussian
- Evolution of mean and variance is deterministic!

$$\begin{aligned} \mu_{\star} &= \mathbf{k}_{\text{NTK}}(\star, \mathcal{D}) \, \mathbf{K}_{\text{NTK}}^{-1} \left(\mathbf{I} - e^{-\eta \mathbf{K}_{\text{NTK}} t} \right) \mathbf{y} \\ \sigma_{\star}^{2} &= k_{\text{NNGP}}(\star, \star) \\ &+ \mathbf{k}_{\text{NTK}}(\star, \mathcal{D}) \, \mathbf{K}_{\text{NTK}}^{-1} \left(\mathbf{I} - e^{-\eta \mathbf{K}_{\text{NTK}} t} \right) \mathbf{K}_{\text{NNGP}} \left(\mathbf{I} - e^{-\eta \mathbf{K}_{\text{NTK}} t} \right) \mathbf{K}_{\text{NTK}}^{-1} \mathbf{k}_{\text{NTK}} (\mathcal{D}, \star) \\ &- \mathbf{k}_{\text{NTK}}(\star, \mathcal{D}) \, \mathbf{K}_{\text{NTK}}^{-1} \left(\mathbf{I} - e^{-\eta \mathbf{K}_{\text{NTK}} t} \right) \mathbf{k}_{\text{NNGP}} (\mathcal{D}, \star) \\ &- \mathbf{k}_{\text{NNGP}}(\star, \mathcal{D}) \left(\mathbf{I} - e^{-\eta \mathbf{K}_{\text{NTK}} t} \right) \mathbf{K}_{\text{NTK}}^{-1} \mathbf{k}_{\text{NTK}} (\mathcal{D}, \star) \end{aligned}$$
[1] Lee et al. arXiv:1711.00165 (2017) [2] Jacot et al. NIPS (2018) [3] Lee et al. NIPS (2019) \end{aligned}

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EXTENSION TO NEURAL NETWORKS

Toy example (from Wikipedia)



EPFL Last-layer Prediction Rigidity (LLPR)

- A last-layer approximation of the prediction rigidity recovers:
 - the NNGP exactly at initialization

$$K_{\text{NNGP}}(\mathbf{x}_i, \mathbf{x}_j) \approx \sigma_w^2 \mathbf{f}_i^\top \mathbf{f}_j \Longrightarrow \mathbf{K}_{\text{NNGP}}(\mathcal{D}, \mathcal{D}) \approx \sigma_w^2 \mathbf{F} \mathbf{F}^\top$$

the NTK to a good approximation

$$K_{\text{NTK}}(\mathbf{x}_i, \mathbf{x}_j) \approx c \left(\frac{\partial \tilde{y}(\mathbf{x}_i, \mathbf{w})}{\partial \mathbf{w}_L}\right)^\top \frac{\partial \tilde{y}(\mathbf{x}_j, \mathbf{w})}{\partial \mathbf{w}_L} = c \mathbf{f}_i^\top \mathbf{f}_j \Longrightarrow \mathbf{K}_{\text{NTK}}(\mathcal{D}, \mathcal{D}) \approx c \mathbf{F} \mathbf{F}^\top$$

EPFL Last-layer Prediction Rigidity (LLPR)

full NTK



Last-layer NTK: weaker dependence on "time"



EPFL California housing \$: NN width test

